

EECS 101: HOMEWORK #2

Due: January 23, 2019

1. Consider an amplified measurement C in electrons for a collection site (potential well) in a cooled CCD camera described by

$$C = (S + N_A + N_P)A$$

where S is the signal in electrons, N_A is a zero-mean amplifier noise source with a variance of 1 electron, N_P is the photon noise source, A is the constant amplifier gain, and N_A and N_P are independent. (Hint: read problem 3 before working on this problem)

- a) Write an expression for the variance of the measurement C .
- b) Define the signal-to-noise of the quantity C as its mean divided by its standard deviation. What is the signal-to-noise for the measurement C ?
- c) For what minimum value of S will the signal-to-noise exceed 100?

2. Consider an imaging system using a lens with focal length 4cm having an image plane 6cm behind the lens. Assume the lens diameter is 2cm.

- a) How far in front of the lens on the optical axis of the system must we place a point to get an image without blur?
- b) Suppose the image plane has an active area of $2\text{cm} \times 2\text{cm}$ which is partitioned into 500×500 square potential wells (collection sites). Suppose the point in part a) images without blur to the center of a potential well. How far can we move the point in focus towards the lens before the image extends to more than one potential well.

3. Assume that we have a CCD camera system that is cooled so that noise due to dark current is negligible. Then digitized pixel values will be given by

$$D = (S + N_A + N_P)A + N_Q \tag{1}$$

where S is the signal in electrons, N_A is the zero-mean amplifier noise source with variance σ_A^2 , N_P is the zero-mean photon noise with variance S , A is the gain of the amplifier, and N_Q is the zero-mean quantization noise with variance σ_Q^2 . Assume that the noise sources are independent.

a) Show that for a constant signal level S the expected value of D is

$$\mu = SA \quad (2)$$

and the variance of D is given by

$$\sigma_D^2 = A\mu + \sigma_C^2 \quad (3)$$

where

$$\sigma_C^2 = A^2\sigma_A^2 + \sigma_Q^2 \quad (4)$$

b) Write a program that reads a digital image $I(x, y)$ of size $N \times N$ where $N = 100$ and estimates μ by

$$\hat{\mu} = \frac{1}{N^2} \sum_{1 \leq x \leq N} \sum_{1 \leq y \leq N} I(x, y) \quad (5)$$

and σ_D^2 by

$$\hat{\sigma}_D^2 = \frac{1}{N^2 - 1} \sum_{1 \leq x \leq N} \sum_{1 \leq y \leq N} (I(x, y) - \hat{\mu})^2 \quad (6)$$

Run your program to find $\hat{\mu}$ and $\hat{\sigma}_D^2$ for each of four images provided by your TA.

c) Plot $\hat{\sigma}_D^2$ versus $\hat{\mu}$ for these four points. Estimate A and σ_C^2 using a least squares fit of the line given by (3) to your data. A program that shows how to read an image will be provided in lab. You are required to demonstrate your program to your TA during lab.